MSKSEMI 美森科













ESD

TV:

SS

GE

PLEC

NVMFD5853NLT1G-MS

Product specification





Description

The NVMFD5853NLT1G-MS uses advanced trench technology to provide excellent RDS(ON), low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

Features

Vps = 40V Ip =50A

 $RDS(ON) < 14m\Omega$ VGS=10V

Application

- Battery protection
- Load switch
- Uninterruptible power supply

Reference News

PACKAGE OUTLINE	N-Channel MOSFET	Marking
PIN1		MSKSEMI D5853NL N40 ●
DFN5X6-8L	S	

Absolute Maximum Ratings (TC=25℃unless otherwise noted)

Symbol	Parameter	Rating	Units
VDS	Drain-Source Voltage	40	V
Vgs	Gate-Source Voltage	±20	V
ID @Tc=25°C	Continuous Drain Current, V gs @ 10V ¹	50	A
ID @Tc=100°C	Continuous Drain Current, V gs @ 10V ¹	38	Α
Ірм	Pulsed Drain Current ²	160	Α
EAS	Single Pulse Avalanche Energy ³	50	mJ
Тѕтс	Storage Temperature Range	-55 to 175	°C
TJ	Operating Junction Temperature Range	-55 to 175	°C



Thermal Characteristic

Thermal Resistance,Junction-to-Case ^(Note 2)	Rejc	1.76	°C/W
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Electrical Characteristics (TA=25℃unless otherwise noted)

Symbol	Parameter Test Condition		Min.	Тур.	Max.	Units
Off Chara	icteristic		1			
V _{(BR)DSS}	Drain-Source Breakdown Voltage	own Voltage V _{GS} =0V, I _D =250µA		-	-	V
IDSS	Zero Gate Voltage Drain Current	V _{DS} =40V, V _{GS} = 0V,	-	-	1	μA
lgss	Gate to Body Leakage Current	$V_{DS}=0V$, $V_{GS}=\pm 20V$	-	-	±100	μΑ
On Chara	cteristics					
$V_{GS(th)}$	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250µA	1.0	1.6	2.5	V
R _{DS(on)}	Static Drain-Source on-Resistance	V _{GS} =10V, I _D =30A	-	11	14	mΩ
g FS	Forward Transconductance	VDS=5V,ID=20A	30	-	-	S
Dynamic C	Characteristics(Note 4)					
C _{iss}	Input Capacitance		_	1540	_	pF
Coss	Output Capacitance	V _{DS} =25V, V _{GS} =0V, f=1.0MHz	_	171	-	pF
Crss	Reverse Transfer Capacitance	1-1.0WH1Z	_	115	-	pF
Switching	Characteristics(Note 4)					
t _{d(on)}	Turn-on Delay Time		_	5	-	ns
t _r	Turn-on Rise Time	V _{DD} =20V, I _D =20A,RL=1Ω	-	24	-	ns
t _{d(off)}	Turn-off Delay Time		-	38	-	ns
t _f	Turn-off Fall Time	V_{GS} =10V, R_{GEN} =3 Ω	-	12	-	ns
Qg	Total Gate Charge		-	24	-	nC
Qgs	Gate-Source Charge	V _{DS} =30V, I _D =30A, V _{GS} =10V	-	5.9	-	nC
Q_{gd}	Gate-Drain Charge		-	3.6	-	nC
Drain-So	urce Diode Characteristics and	Maximum Ratings	-			
l s	Drain Forward Current ^(Note 2)		_	_	48	А
VsD	Drain Forward Current ^(Note 3)	V _{GS} =0V, I _S =30A		-	1.2	V
trr	Reverse Recovery Time	TJ=25°C, IF=30A	-	9	-	ns
Qrr	Reverse Recovery Charge	di/dt=100A/µs ^(Note 3)	-	15	-	nC
ton	Forward Turn-On Time Intrinsic turn-on time is negligible(turn-on is dominated br LS+LD					I S+I D

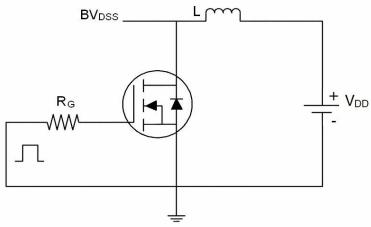
Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. Surface Mounted on FR4 Board, t≤10 sec.
- 3. Pulse Test: Pulse Width ≤ 300µs, Duty Cycle≤2%.
- 4. Guaranteed by design, not subject to production
- 5. Eas condition: Tj=25 $^{\circ}$ C,VDD=30V,VG=10V,L=0.5mH,Rg=25 Ω

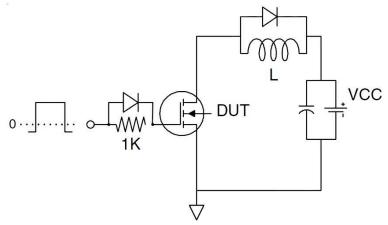


Test circuit

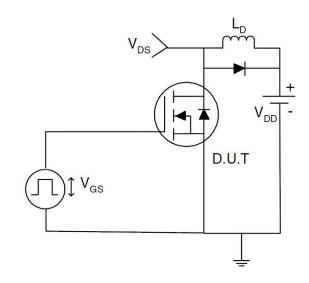
1) E_{AS} test Circuits



2) Gate charge test Circuit

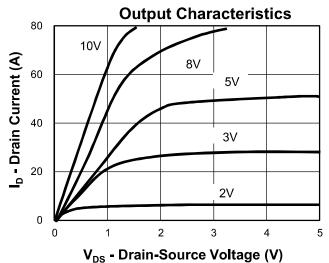


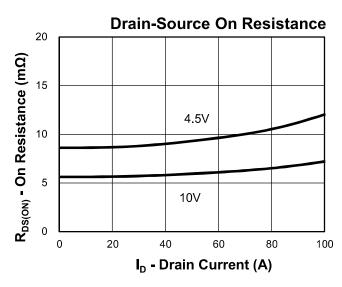
3) Switch Time Test Circuit

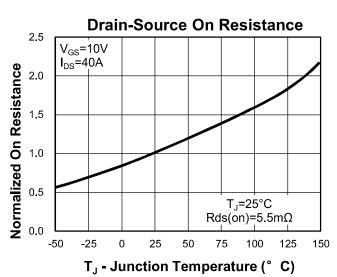


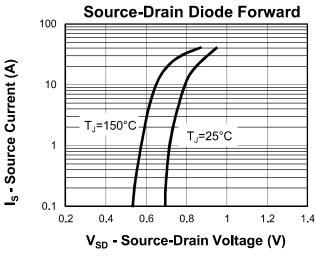


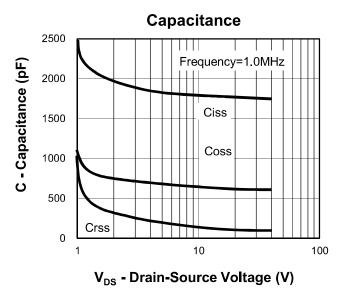
Typical Characteristics

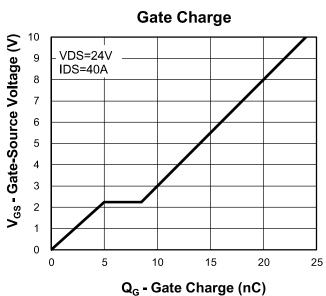






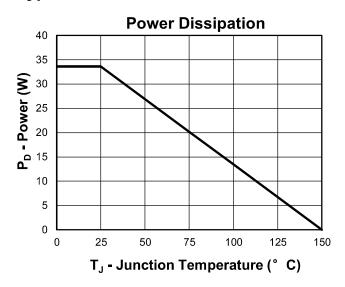


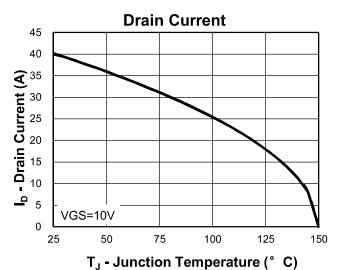


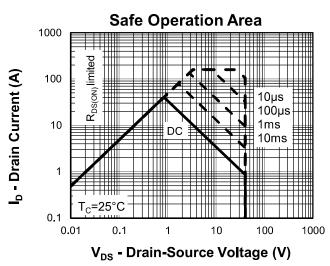


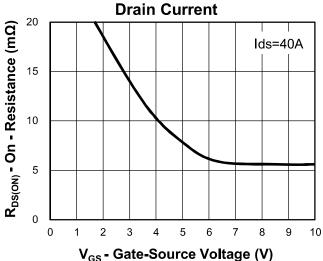


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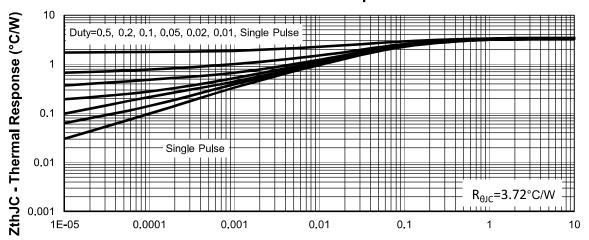








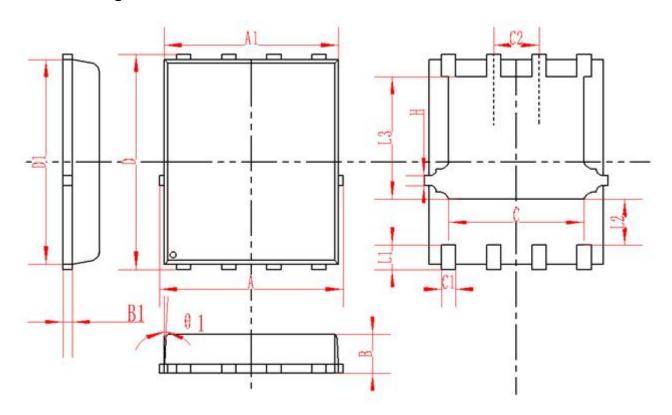
Thermal Transient Impedance



Square Wave Pulse Duration (sec)



DFN5X6-8L Package Information



SYMBOL	MM			INCH		
STIVIDUL	MIN	NOM	MAX	MIN	NOM	MAX
А	4.95	5	5.05	0.195	0.197	0.199
A1	4.82	4.9	4.98	0.190	0.193	0.196
D	5.98	6	6.02	0.235	0.236	0.237
D1	5.67	5.75	5.83	0.223	0.226	0.230
В	0.9	0.95	1	0.035	0.037	0.039
B1	0.254REF		0.010REF			
С	3.95	4	4.05	0.156	0.157	0.159
C1	0.35	0.4	0.45	0.014	0.016	0.018
C2	1.27TYP		0.5TYP			
θ1	8。	10 _°	12 _°	8。	10 _°	12。
L1	0.63	0.64	0.65	0.025	0.025	0.026
L2	1.2	1.3	1.4	0.047	0.051	0.055
L3	3.415	3.42	3.425	0.134	0.135	0.135
Н	0.24	0.25	0.26	0.009	0.010	0.010

REEL SPECIFICATION

P/N	PKG	QTY
NVMFD5853NLT1G-MS	DFN5X6-8L	5000



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